

40V P-Channel Trench MOSFET(Preliminary)

General Description

- Trench Power technology
- Low R_{DS(ON)}
- Low Gate Charge
- Optimized for fast-switching applications

Applications

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

Product Summary

 V_{DS} -40V I_{D} (at V_{GS} =-10V) -5A

 $R_{DS(ON)}$ (at V_{GS} =-10V) < 75m Ω

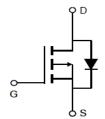
 $R_{DS(ON)}$ (at V_{GS} =-4.5V) < 117m Ω

100% UIS Tested



SOP-8





Part Number	Package Type	Form	Marking
TTJ05P04AT	SOP-8	Tape&Reel	05P04AT

Absolute Maximum Ratings (T_A =25°C unless otherwise noted)

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	- 40	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current B	T _C =25°C	- I _D	-5	٨
Continuous Drain Current B	T _C =70°C		-4	Α
Pulsed Drain Current ^A		I _{DM}	-15	Α
Avalanche Current A		I _{AS}	-7.8	А
Single Pulse Avalanche Energy L =0.3mH A		E _{AS}	9.1	mJ
Power Dissipation ^C	T _C =25°C	Б	12.9	W
	T _C =70°C	P _D	6.5	W
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics

Parameter		Symbol	Maximum	Units
Maximum Junction-to-Case	Steady-State	R _{⊕JC}	11.6	00.444
Maximum Junction-to-Ambient	Steady-State	$R_{\Theta JA}$	50	°C/W



		Conditions		Value			
Symbol	Parameter			Min	Тур	Max	Units
STATIC P	ARAMETERS	•				!	
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =-250μA,V _{GS} =0V		-40			V
		$V_{DS} = -40V, V_{GS} = 0V$	T _J =25°C			-1	μΑ
I _{DSS}	Zero Gate Voltage Drain Current		T _J =100°C			-100	
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	1			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA		-1	-1.7	-2.4	V
		V _{GS} =-10V, I _D =-2.5A			62	75	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance	V _{GS} =-4.5V, I _D =-2.5A			97	117	mΩ
g _{FS}	Forward Transconductance	V _{DS} =-5V, I _D =-2.5A			51		S
V_{SD}	Diode Forward Voltage	I _S =-2.5A, V _{GS} =0V				-1	V
Is	Maximum Body-Diode Continuous Curre	nt ^B				-5	Α
DYNAMIC	PARAMETERS					•	
C _{iss}	Input Capacitance				665		
C _{oss}	Output Capacitance	$V_{GS} = 0V$, $V_{DS} = -20V$, $f = 1MH_Z$			57		pF
C _{rss}	Reverse Transfer Capacitance				29		
SWITCHI	NG PARAMETERS	•				•	
Q _g (10V)	Total Gate Charge				25		
Q_{gs}	Gate Source Charge	$V_{GS} = -10V, V_{DS} = -20V, I_{D} = -2.5A$			9		nC
Q_{gd}	Gate Drain Charge				7		
t _{D(on)}	Turn-On Delay Time				10		
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-20V, I_{D} =-2.5A, R_{G} =3 Ω			9		ns
$T_{D(off)}$	Turn-Off Delay Time				29		
t _f	Turn-Off Fall Time				11		
t _{rr}	Body Diode Reverse Recovery Time	1 0 5 A 32/34 400 A	1		18		ns
Q _{rr}	Body Diode Reverse Recovery Charge	$I_F = -2.5A$, di/dt = 100A	/µs		12		nC

- A. Single pulse width limited by maximum junction temperature.
- B. The maximum current rating is package limited.
- C. The power dissipation P_D is based on $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.



Typical Characteristics $T_J = 25^{\circ}\text{C}$, unless otherwise noted

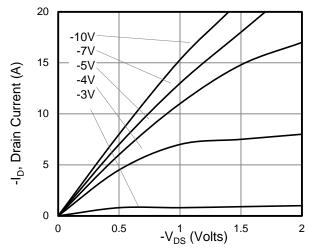


Figure 1: On-Region Characteristics

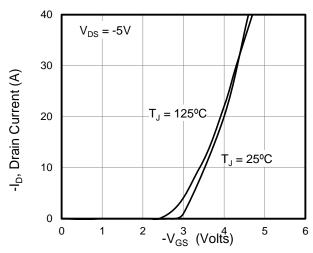


Figure 2: Transfer Characteristics

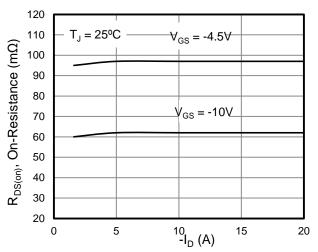


Figure 3: On-Resistance vs. Drain Current

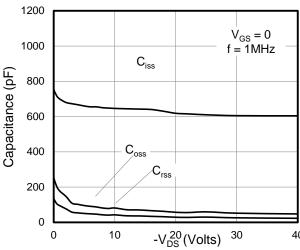


Figure 4: Capacitance Characteristics

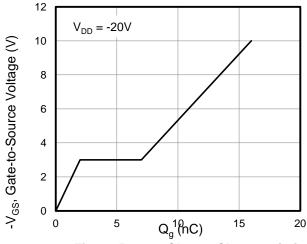


Figure 5: Gate Charge Characteristics

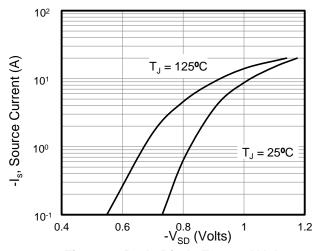
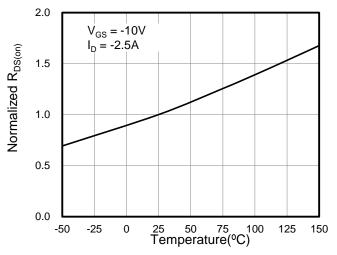


Figure 6: Body Diode Forward Voltage

 $Z_{\theta,JC}$ Normalized Transient Thermal Resistance

Typical Characteristics $T_J = 25^{\circ}C$, unless otherwise noted



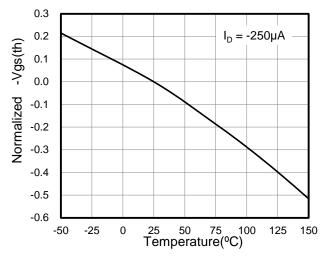
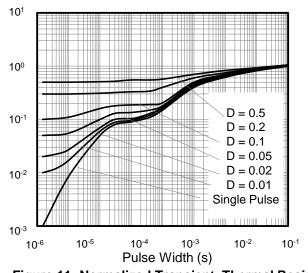


Figure 7: On-Resistance vs. Junction Temperature

Figure 8: Vgs(th) vs. Junction Temperature



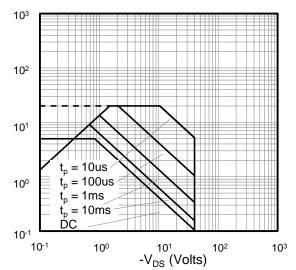


Figure 11: Normalized Transient Thermal Resistance

Figure 12: Safe Operating Area

-I_D (Amps)

Figure A: Gate Charge Test Circuit and Waveform

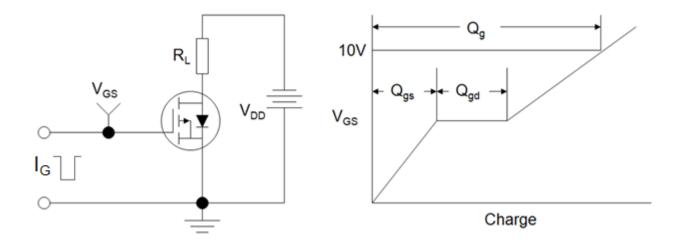


Figure B: Resistive Switching Test Circuit and Waveform

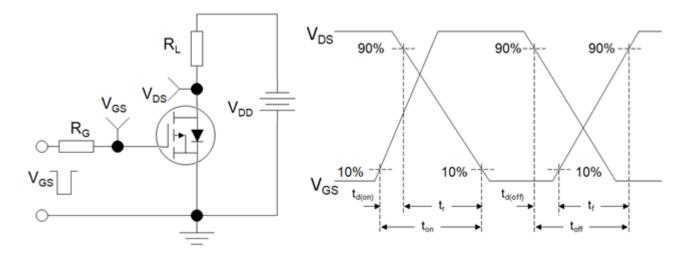
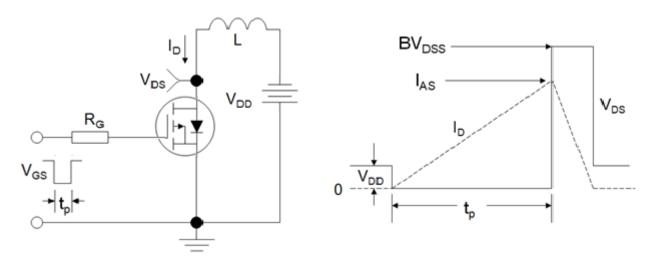
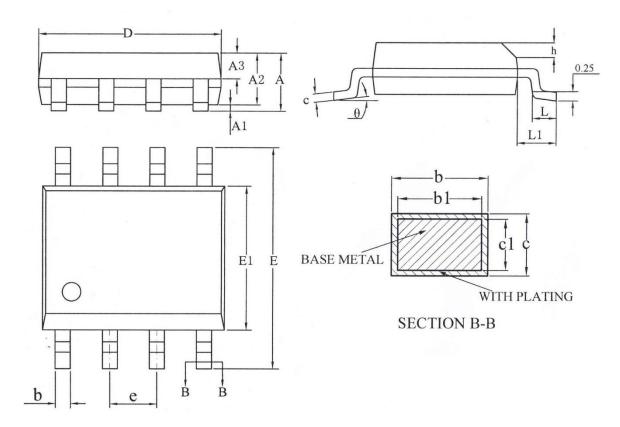


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





SOP-8(捷敏)



SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
A		_	1.75	
A1	0.10	_	0.225	
A2	1.30	1.40	1.50	
A3	0.60	0.65	0.70	
b	0.39	_	0.48	
b1	0.38	0.41	0.43	
С	0.21	_	0.26	
c1	0.19	0.20	0.21	

SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
D	4.70	4.90	5.10	
Е	5.80	6.00	6.20	
E1	3.70	3.90	4.10	
e	1.27BSC			
h	0.25	_	0.50	
L	0.50		0.80	
L1	1.05BSC			
θ	0		8°	



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